

**Notice of References Cited**

Application/Control No.

10/023,920

Applicant(s)/Patent Under Reexam

Tagge et al.

Examiner

J. Pasterczyk

Art Unit

1755

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**U.S. PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
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B	5,852,146	12/1998	Reichle et al.	526	172
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**NON-PATENT DOCUMENTS**

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
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<sup>1</sup> Dates in MM-YYYY format are publication dates.<sup>2</sup> Classifications may be U.S. or foreign.